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# United States Patent [19]

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Fukumoto et al.

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[54] **HARDNESS TESTING APPARATUS**

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[73] Assignee: **Matsuzawa Seiki Kabushikikaisha**, Tokyo, Japan

[\*\*] Term: **14 Years**

[21] Appl. No.: **7,935**

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[30] **Foreign Application Priority Data**

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[52] U.S. Cl. .... **D10/75**

[58] Field of Search ..... **D10/46, 75; 73/78, 79, 73/80, 81, 82, 83, 84; 356/378**

[56] **References Cited**

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[57] **CLAIM**

The ornamental design of a hardness testing apparatus, as shown and described.

**DESCRIPTION**

FIG. 1 is a frontal elevational view showing the new design of the present invention;  
FIG. 2 is a top plan view showing the new design of the present invention;  
FIG. 3 is a rear elevational view showing the new design of the present invention;  
FIG. 4 is a bottom view showing the new design of the present invention;  
FIG. 5 is a side view showing the new design of the present invention from the right side relative to the view of FIG. 1; and,  
FIG. 6 is a side view showing the new design of the present invention from the left side relative to the view of FIG. 1.

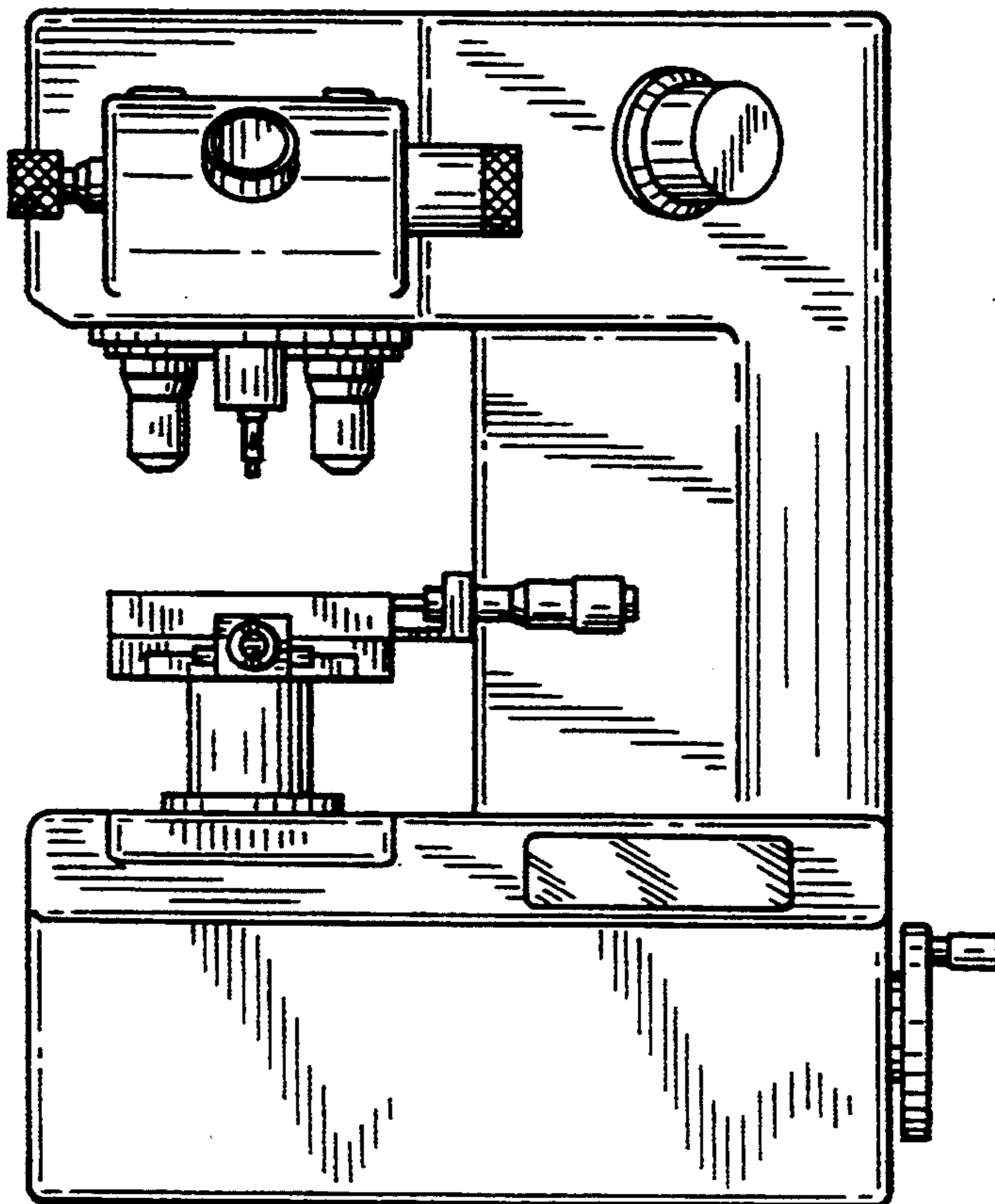


FIG. 1

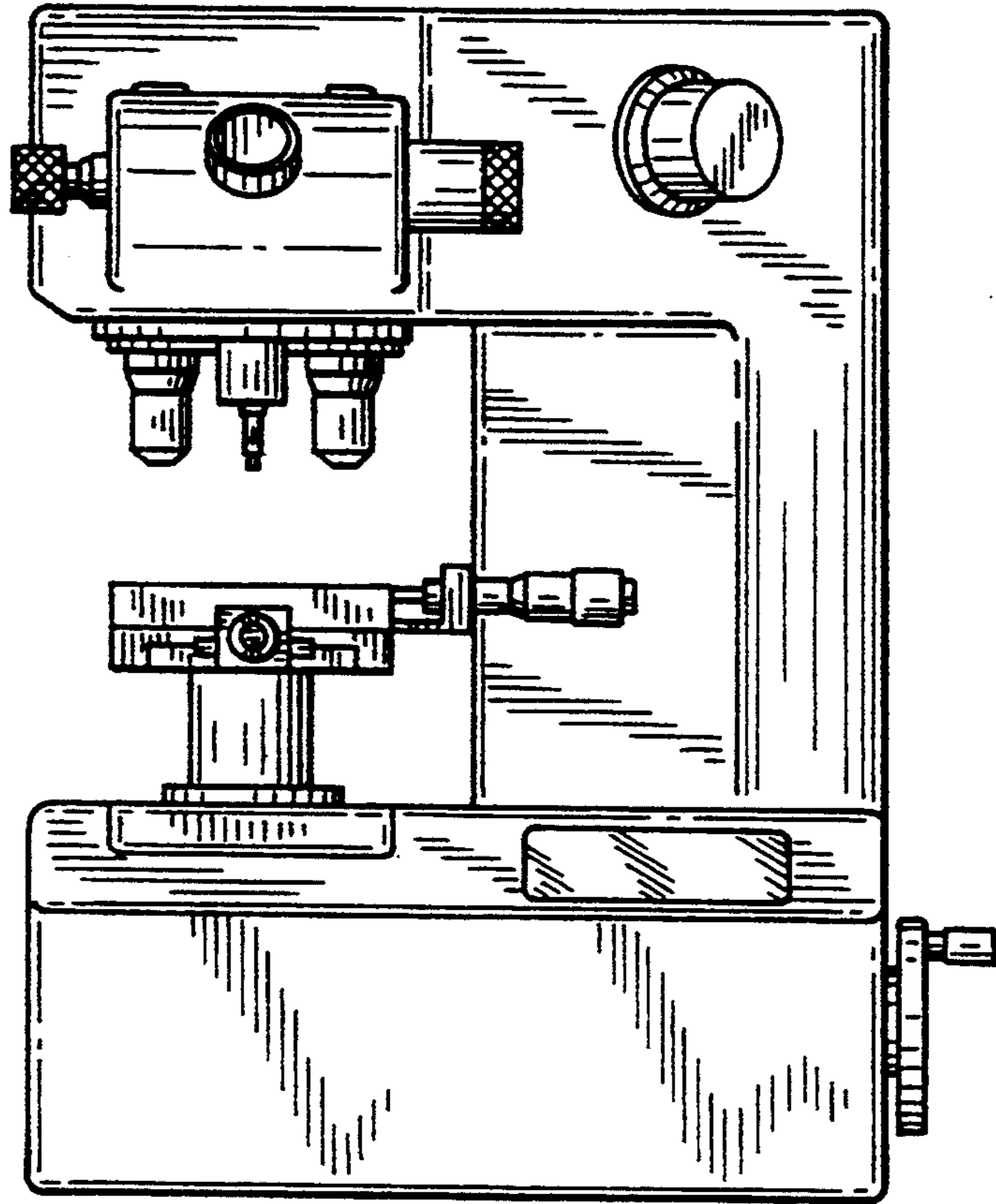
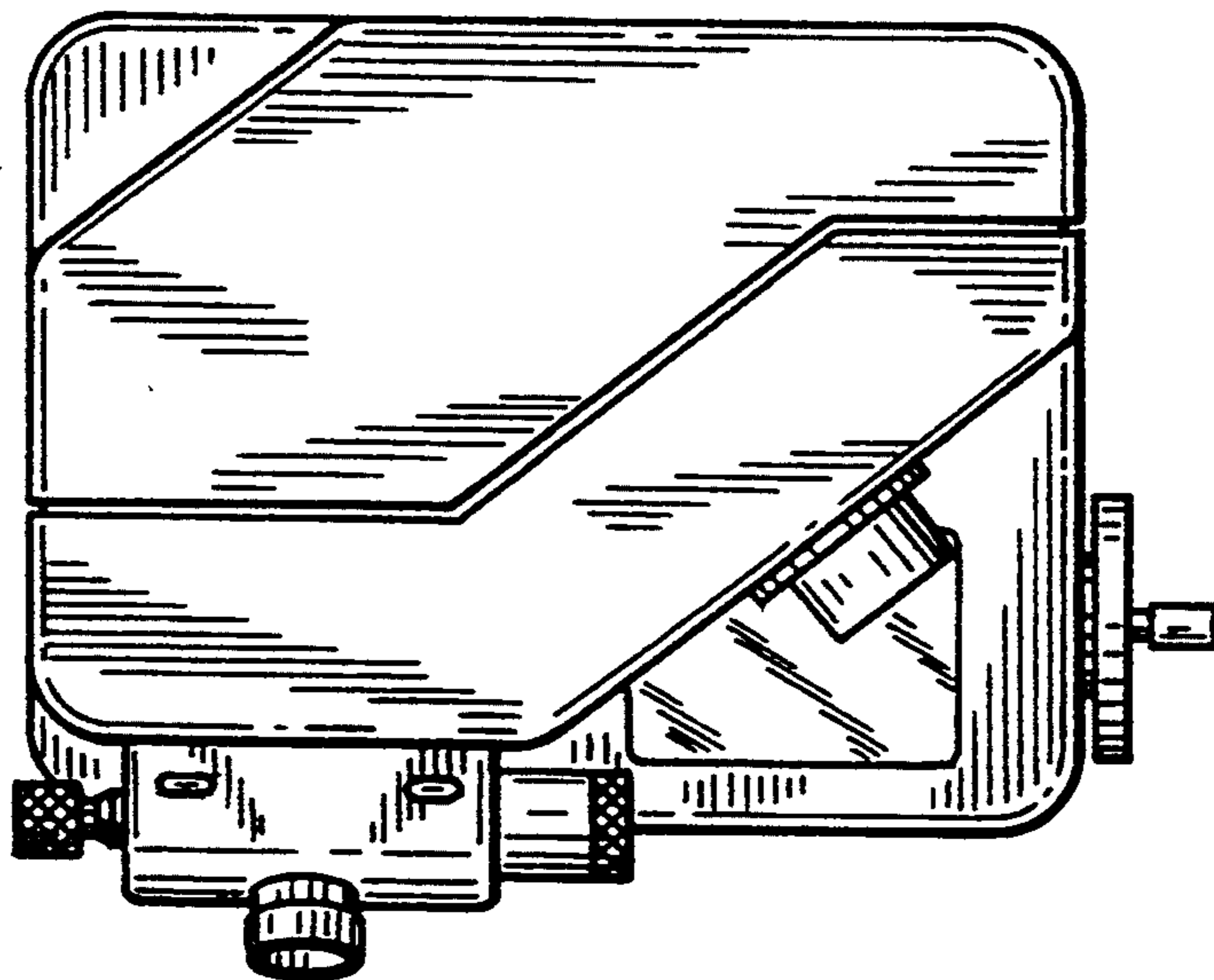
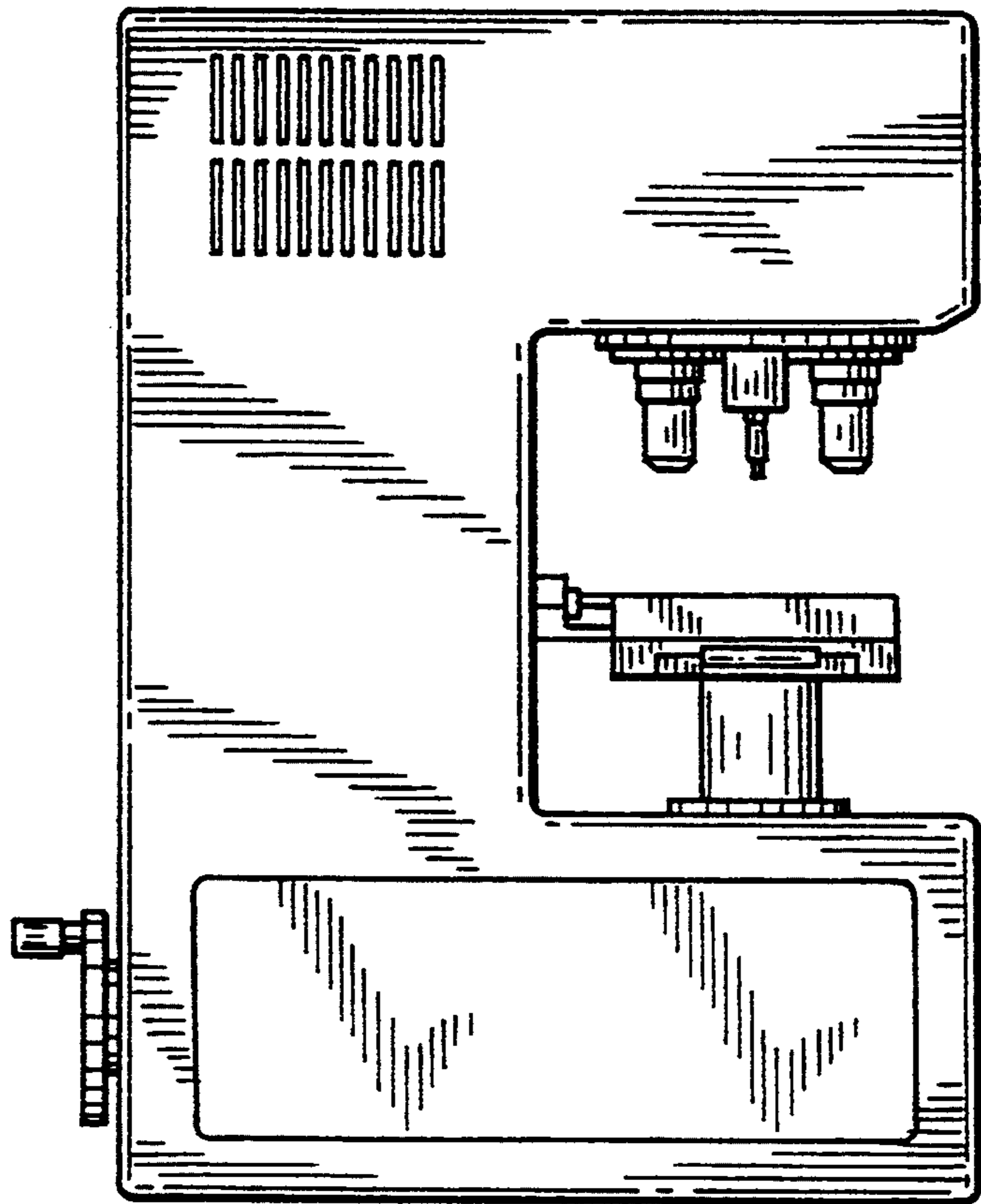


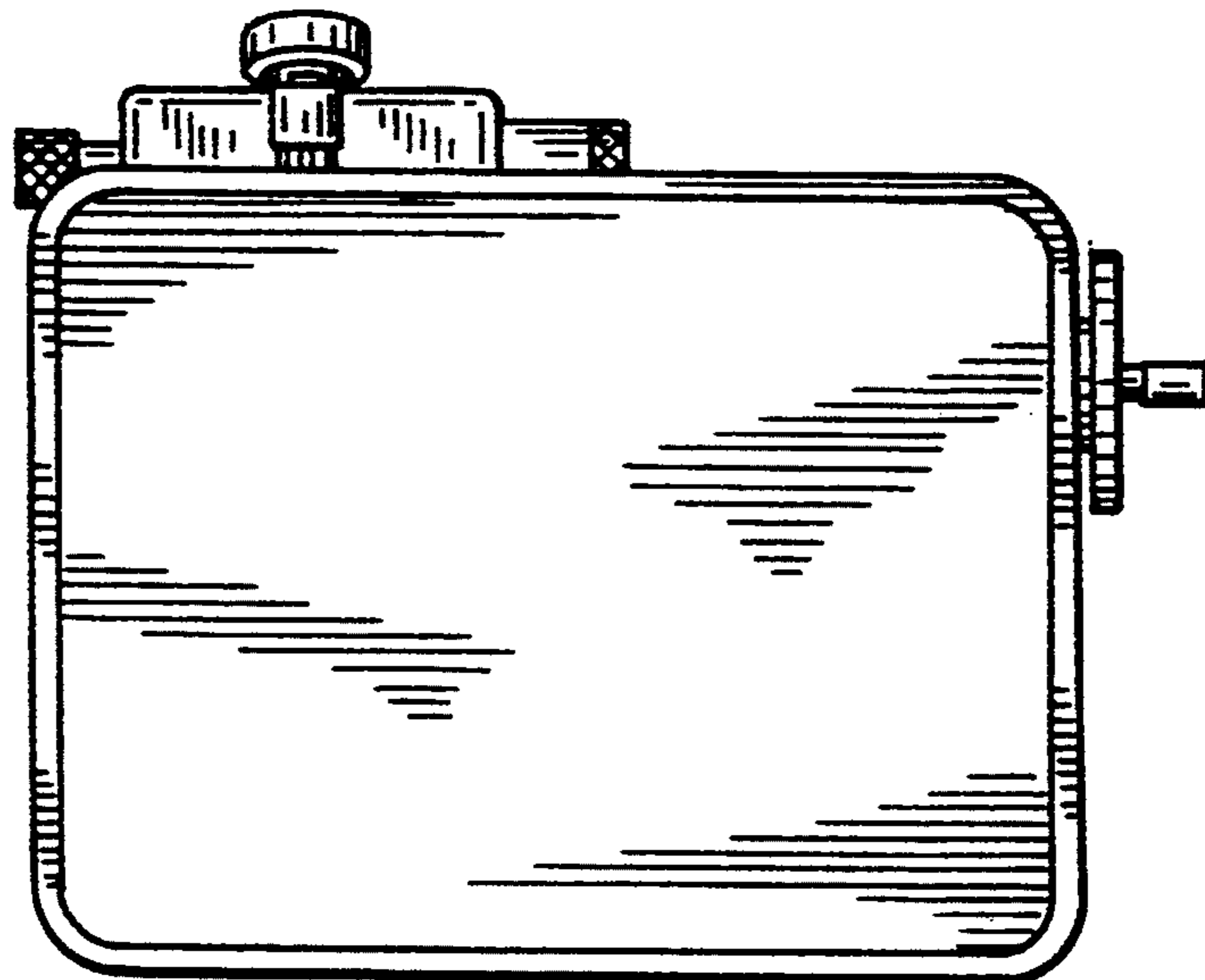
FIG. 2



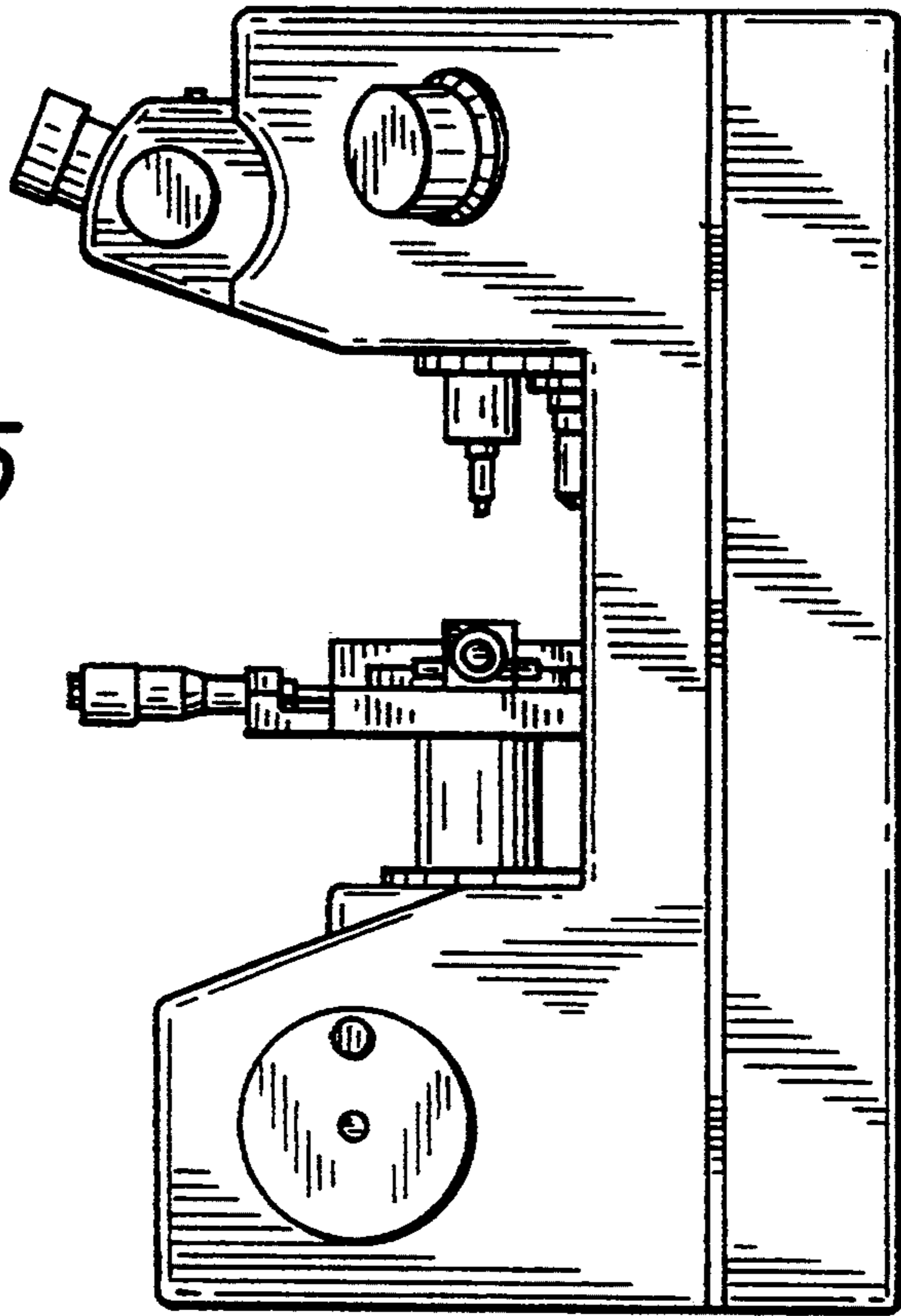
*FIG. 3*



*FIG. 4*



*FIG. 5*



*FIG. 6*

